

SIGC14T60NC

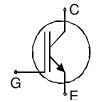
IGBT Chip in NPT-technology

FEATURES:

- 600V NPT technology
- 100µm chip
- positive temperature coefficient
- easy paralleling

This chip is used for:

IGBT Modules



Applications:

• drives

Chip Type	V _{CE}	I _{Cn}	Die Size	Package	Ordering Code	
SIGC14T60NC	600V	15A	3.8 x 3.8 mm ²	sawn on foil	Q67050-A4135-	
313014100110	000 V	134	3.0 X 3.0 IIIIII	Sawii Oii ioii	A001	

MECHANICAL PARAMETER:

Raster size	3.8 x 3.8					
Area total / active	14.44 / 10.7]				
Emitter pad size	1.89 x 2.19]				
Gate pad size	0.7 x 1.09]				
Thickness	100	μm				
Wafer size	150	mm				
Flat position	0	deg				
Max.possible chips per wafer	1032					
Passivation frontside	Photoimide					
Emitter metallization	3200 nm Al Si 1%	3200 nm Al Si 1%				
Collector metallization	1400 nm Ni Ag -system suitable for epoxy and soft solder die bonding					
Die bond	electrically conductive glue or solder					
Wire bond	Al, ≤500μm					
Reject Ink Dot Size	Ø 0.65mm ; max 1.2mm					
Recommended Storage Environment	store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C					



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MAXIMUM RATINGS:

Parameter	Symbol	Value	Unit
Collector-emitter voltage, T_j =25 °C	V _{CE}	600	V
DC collector current, limited by T _{jmax}	I _C	1)	А
Pulsed collector current, t _p limited by T _{jmax}	I _{cpuls}	45	А
Gate emitter voltage	V_{GE}	±20	V
Operating junction and storage temperature	T_j , T_{stg}	-55 +150	°C

¹⁾ depending on thermal properties of assembly

STATIC CHARACTERISTICS (tested on chip), T_j =25 °C, unless otherwise specified:

Parameter	Symbol	Conditions	Value			Unit
Tarameter			min.	typ.	max.	5.111
Collector-emitter breakdown voltage	V _{(BR)CES}	V_{GE} =0V, I_{C} =500 μ A	600			
Collector-emitter saturation voltage	V _{CE(sat)}	V _{GE} =15V, I _C =15A	1.7	2.0	2.5	V
Gate-emitter threshold voltage	$V_{GE(th)}$	$I_C=400\mu A,\ V_{GE}=V_{CE}$	4.5	5.5	6.5	
Zero gate voltage collector current	I _{CES}	V_{CE} =600V, V_{GE} =0V			1.1	μΑ
Gate-emitter leakage current	I _{GES}	$V_{CE}=0V$, $V_{GE}=20V$			120	nA

DYNAMIC CHARACTERISTICS (tested at component):

Parameter	Symbol	Conditions	Value			Unit
raiailietei			min.	typ.	max.	Ollit
Input capacitance	Ciss	V _{CE} =25V,	-	675	-	pF
Output capacitance	Coss	$V_{\text{GE}}=0\text{V}$,	-	tbd	-	
Reverse transfer capacitance	C_{rss}	f=1MHz	-	60	-	

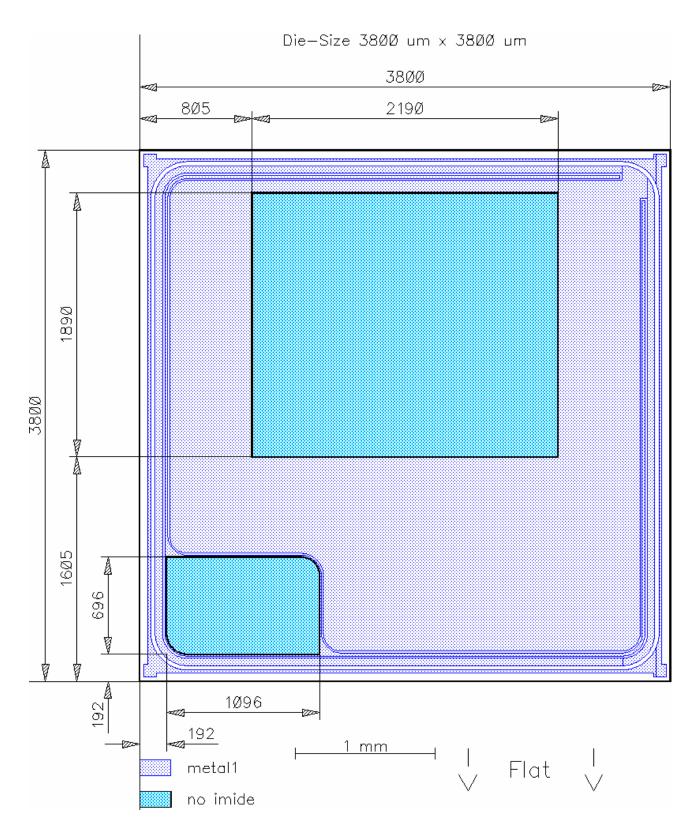
SWITCHING CHARACTERISTICS (tested at component), Inductive Load:

Parameter	Symbol	Conditions 1)	Value			Unit
raiametei			min.	typ.	max.	Oilit
Turn-on delay time	$t_{d(on)}$	T _j =125°C V _{CC} =300V	-	21	-	ns
Rise time	t _r	I _C =15A	-	8	-	
Turn-off delay time	$t_{d(off)}$	$V_{\rm GE}$ =±15V $R_{\rm G}$ =18 Ω	-	110	-	
Fall time	t_{f}	71G-1032	-	25	-	

¹⁾ values also influenced by parasitic L- and C- in measurement and package.



CHIP DRAWING:





SIGC14T60NC

FURTHER ELECTRICAL CHARACTERISTICS:

This chip data sheet refers to the device data sheet

FS 15 R06 XL4

Description:

AQL 0,65 for visual inspection according to failure catalog

Electrostatic Discharge Sensitive Device according to MIL-STD 883

Test-Normen Villach/Prüffeld

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